

DIM800DDM12-A000

Dual Switch IGBT Module

Replaces DS5528-3.0

DS5528-4 October 2009 (LN26748)

FEATURES

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- Non Punch Through Silicon
- Isolated AISiC Base with AIN Substrates
- Lead Free construction

APPLICATIONS

- High Reliability Inverters
- Motor Controllers
- **Traction Drives**

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM800DDM12-A000 is a dual switch 1200V, nchannel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

DIM800DDM12-A000

Note: When ordering, please use the complete part number

KEY PARAMETERS

V_{CES}		1200V
V _{CE(sat)}	* (typ)	2.2 V
l _c ` ´	(max)	800A
I _{C(PK)}	(max)	1600A

^{*} Measured at the power busbars, not the auxiliary terminals

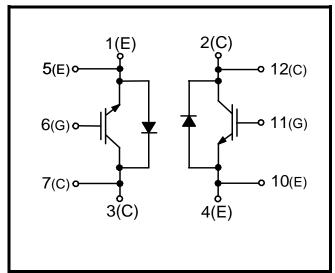


Fig. 1 Circuit configuration

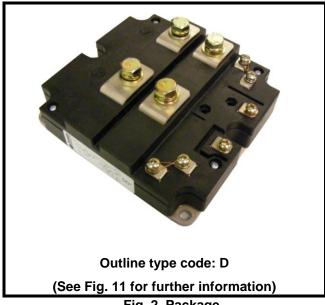


Fig. 2 Package



ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V _{CES}	Collector-emitter voltage	V _{GE} = 0V	1200	V
V_{GES}	Gate-emitter voltage		±20	٧
I _C	Continuous collector current	T _{case} = 85°C	800	Α
I _{C(PK)}	Peak collector current	1ms, T _{case} = 115°C	1600	Α
P _{max}	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{j} = 150^{\circ}C$	6940	W
l ² t	Diode I ² t value	$V_R = 0$, $t_p = 10$ ms, $T_j = 125$ °C	100	kA ² s
V _{isol}	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	2500	V
Q_{PD}	Partial discharge – per module	IEC1287, V ₁ = 1300V, V ₂ = 1000V, 50Hz RMS	10	рС

THERMAL AND MECHANICAL RATINGS

Internal insulation material:

Baseplate material:

Creepage distance:

Clearance:

CTI (Comparative Tracking Index):

AIN

AISiC

20mm

10mm

350

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
R _{th(j-c)}	Thermal resistance – transistor (per switch)	Continuous dissipation - junction to case		-	18	°C/kW
R _{th(j-c)}	Thermal resistance – diode (per switch)	Continuous dissipation - junction to case		-	40	°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (per module)	Mounting torque XNm (with mounting grease)		-	8	°C/kW
T _j	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	125	°C
T _{stg}	Storage temperature range	-	-40	-	125	°C
	Screw torque	Mounting – M6	1	-	5	Nm
		Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm



ELECTRICAL CHARACTERISTICS

 T_{case} = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
	Collector cut-off current	$V_{GE} = 0V$, $V_{CE} = V_{CES}$			1	mA
I _{CES}		$V_{GE} = 0V, V_{CE} = V_{CES}, T_{case} = 125^{\circ}$	С		25	mA
I _{GES}	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$			4	μΑ
V _{GE(TH)}	Gate threshold voltage	$I_C = 40$ mA, $V_{GE} = V_{CE}$	4.5	5.5	6.5	V
\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	Collector-emitter	V _{GE} = 15V, I _C = 800A		2.2	2.8	V
V _{CE(sat)} †	saturation voltage	$V_{GE} = 15V, I_C = 800A, T_j = 125^{\circ}C$		2.6	3.2	V
I _F	Diode forward current	DC			800	Α
I _{FM}	Diode maximum forward current	t _p = 1ms			1600	Α
\	Diode forward voltage	I _F = 800A		2.1	2.4	V
V _F [†]		I _F = 800A, T _j = 125°C		2.1	2.4	V
C _{ies}	Input capacitance	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$		90		nF
Qg	Gate charge	±15V		9		μC
C _{res}	Reverse transfer capacitance	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$				nF
L _M	Module inductance – per switch			20		nΗ
R _{INT}	Internal transistor resistance – per switch			270		μΩ
SC-	Short circuit current, I _{SC}	$T_j = 125$ °C, $V_{CC} = 900$ V $t_p \le 10\mu s$, $V_{GE} \le 15$ V	I ₁	5500		А
SC _{Data}		$V_{CE (max)} = V_{CES} - L^* x dI/dt$ IEC 60747-9		4500		А

Note:

 $[\]stackrel{\uparrow}{}$ Measured at the power busbars, not the auxiliary terminals L is the circuit inductance + L_{M}



ELECTRICAL CHARACTERISTICS

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	$I_{C} = 800A$ $V_{GF} = \pm 15V$		1250		ns
t _f	Fall time			170		ns
E _{OFF}	Turn-off energy loss	$V_{CE} = 600V$		130		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 2.7\Omega$		250		ns
t _r	Rise time	$R_{G(OFF)} = 2.7\Omega$ $L_S \sim 100$ nH		250		ns
E _{ON}	Turn-on energy loss	25 1001111		80		mJ
Q _{rr}	Diode reverse recovery charge	I _F = 800A		80		μC
I _{rr}	Diode reverse recovery current	V _{CE} = 600V		380		Α
E _{rec}	Diode reverse recovery energy	$dI_F/dt = 4200A/\mu s$		30		mJ

T_{case} = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	$I_{C} = 800A$ $V_{GE} = \pm 15V$		1500		ns
t _f	Fall time			200		ns
E _{OFF}	Turn-off energy loss	$V_{CE} = 600V$		160		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 2.7\Omega$ $R_{G(OFF)} = 2.7\Omega$ $L_S \sim 100 \text{nH}$		400		ns
t _r	Rise time			220		ns
E _{ON}	Turn-on energy loss			120		mJ
Q_{rr}	Diode reverse recovery charge	$I_F = 800A$ $V_{CE} = 600V$ $dI_F/dt = 4000A/\mu s$		160		μC
I _{rr}	Diode reverse recovery current			450		Α
E _{rec}	Diode reverse recovery energy			60		mJ



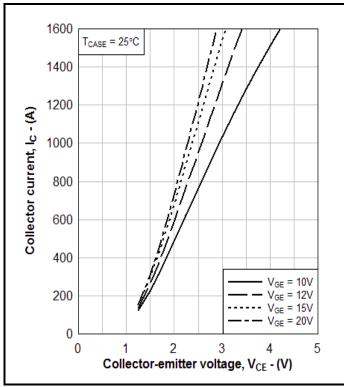


Fig. 3 Typical output characteristics

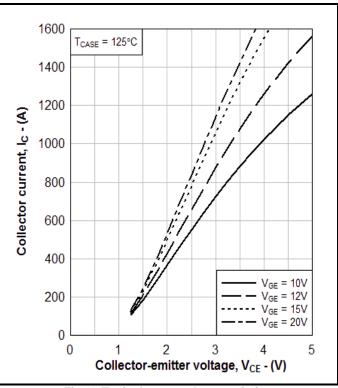


Fig. 4 Typical output characteristics

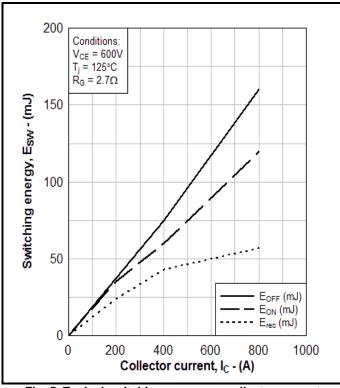


Fig. 5 Typical switching energy vs collector current

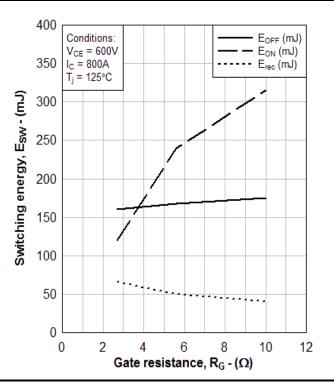


Fig. 6 Typical switching energy vs gate resistance



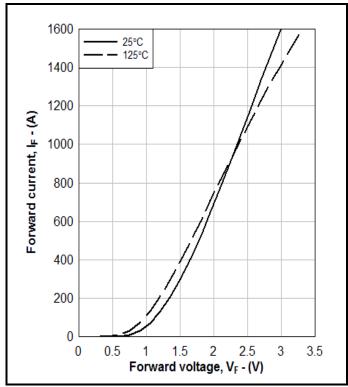


Fig. 7 Diode typical forward characteristics

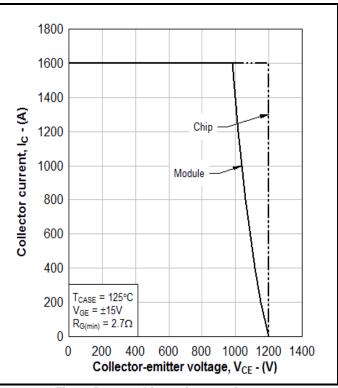


Fig. 8 Reverse bias safe operating area

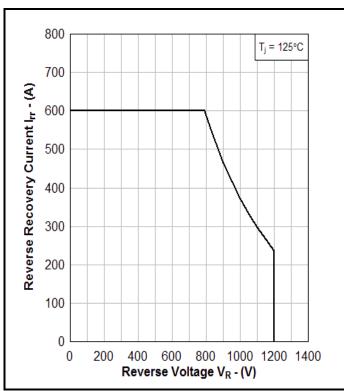


Fig. 9 Diode reverse bias safe operating area

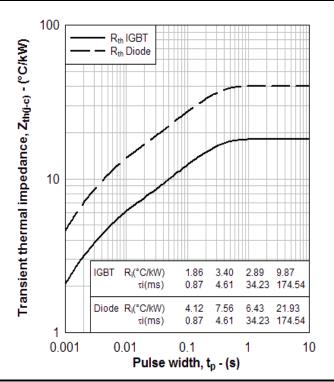


Fig. 10 Transient thermal impedance



PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise.

DO NOT SCALE.

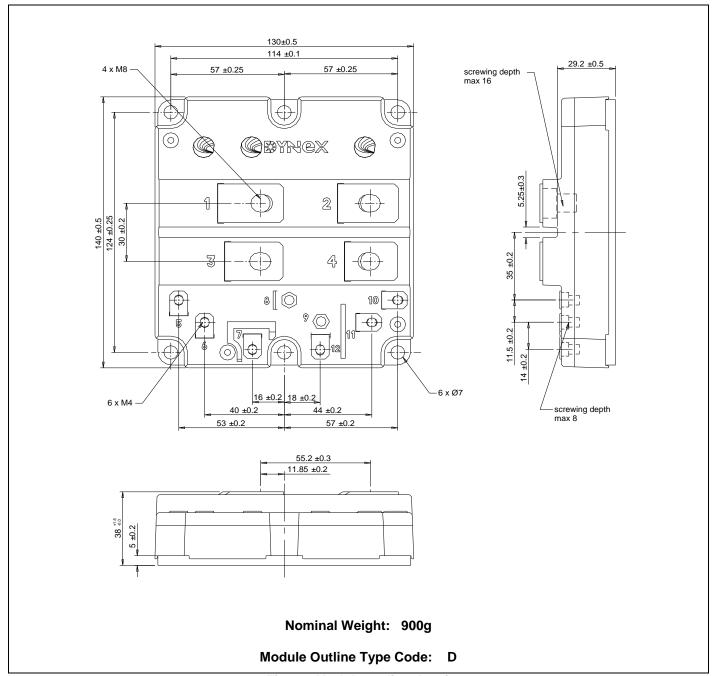


Fig. 11 Module outline drawing



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